

ON Semiconductor® FDV304P **Digital FET, P-Channel**

General Description

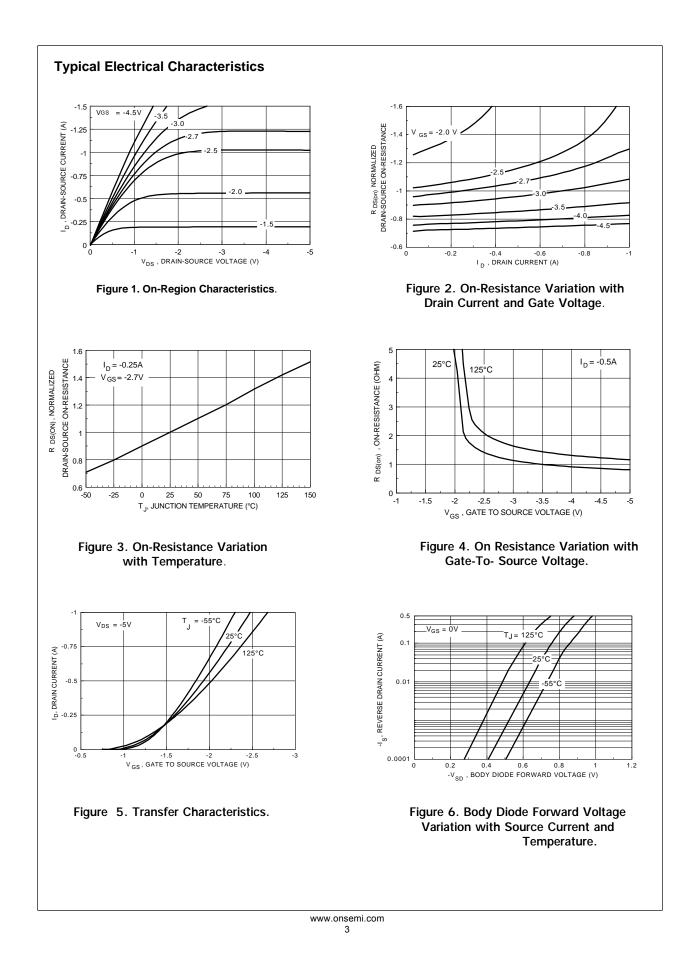
This P-Channel enhancement mode field effect transistors is produced using ON Semiconductor's proprietary, high cell density, DMOS technology. This very high density process is tailored to minimize on-state resistance at low gate drive conditions. This device is designed especially for application in battery power applications such as notebook computers and cellular phones. This device has excellent on-state resistance even at gate drive voltages as low as 2.5 volts.

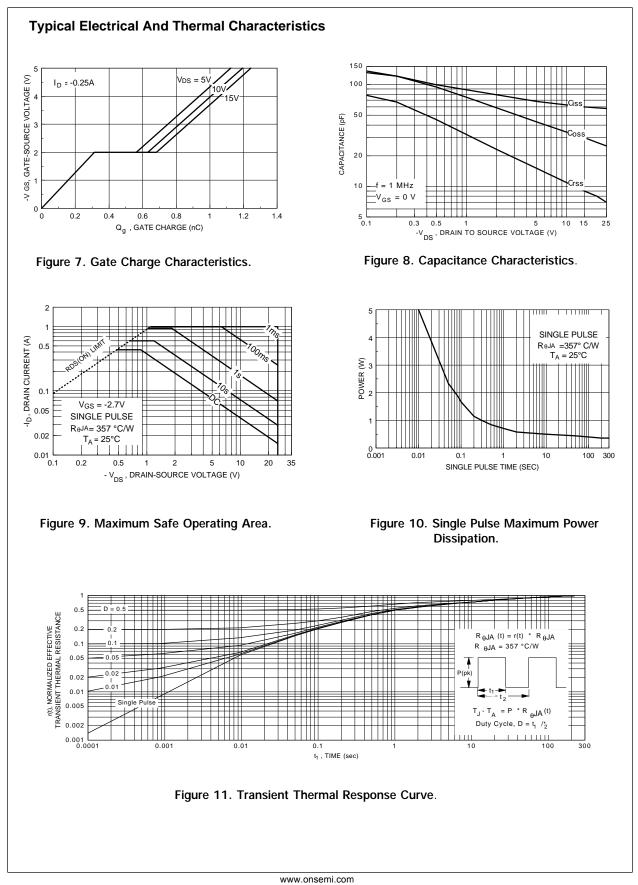
Features

- -25 V, -0.46 A continuous, -1.5 A Peak. $R_{\rm DS(ON)} = 1.1 \ \Omega \ @ V_{\rm GS} = -4.5 \ V$ $R_{\text{DS(ON)}} = 1.5 \ \Omega \ @ V_{\text{GS}} = -2.7 \ V.$
- Very low level gate drive requirements allowing direct operation in 3V circuits. $V_{GS(th)} < 1.5V$.
- Gate-Source Zener for ESD ruggedness. >6kV Human Body Model
- Compact industry standard SOT-23 surface mount package.

S	OT-23	SuperSOT [™] -6	SuperSOT [™] -8	SO-8	SOT-223	SOIC-16		
Mark:304				SO-8 SOT-223 SOIC-16				
		G SOT-23			G			
	ute Maxim		25°C unless other wise note	d	G S FDV304P	Units		
Symbol		um Ratings $T_A = 2$	25°C unless other wise note	d		Units V		
Symbol V _{DSS}	Parameter	u m Ratings T _A = 2 e Voltage	25°C unless other wise note	d	FDV304P			
Symbol V _{DSS} V _{GSS}	Parameter Drain-Sourc	um Ratings T _A = 2 e Voltage e Voltage		d	FDV304P -25	V		
Symbol V _{DSS} V _{GSS}	Parameter Drain-Source Gate-Source Drain Curre	um Ratings T _A = 2 e Voltage e Voltage nt - Continu		d	FDV304P -25 -8 -0.46	V V		
Symbol V _{DSS} V _{GSS} D P	Parameter Drain-Source Gate-Source Drain Curree Maximum P	um Ratings T _A = 2 e Voltage e Voltage nt - Continu - Pulsed	JOUS	d	FDV304P -25 -8 -0.46 -1.5	V V A		
Symbol V _{DSS} V _{GSS} I _D P _D T _J ,T _{STG}	Parameter Drain-Source Gate-Source Drain Curree Maximum P Operating a Electrostatic	um Ratings T _A = 2 e Voltage e Voltage nt - Continu - Pulsed ower Dissipation	e Range	d	FDV304P -25 -8 -0.46 -1.5 0.35	V V A W		
Symbol V _{DSS} V _{GSS} I _b P _D T_J,T _{STG} ESD	Parameter Drain-Source Gate-Source Drain Curree Maximum P Operating a Electrostatic	um Ratings T _A = 2 e Voltage e Voltage nt - Continu - Pulsed ower Dissipation nd Storage Temperature c Discharge Rating MIL y Model (100pf / 1500	e Range	d	FDV304P -25 -8 -0.46 -1.5 0.35 -55 to 150	V V A W ℃C		

Parameter CTERISTICS Drain-Source Breakdown Voltage Breakdown Voltage Temp. Coefficient Zara Cata Valtage Drain Currant		1	Тур	Max	Units
Breakdown Voltage Temp. Coefficient				1	
	$V_{GS} = 0 V, I_{D} = -250 \mu A$	-25			V
Zara Cata Valtaga Drain Current	$I_p = -250 \mu$ A, Referenced to 25 °C		-22		mV /°C
Zero Gate Voltage Drain Current	$V_{DS} = -20 V, V_{GS} = 0 V$			-1	μA
-	T ₁ = 55°C			-10	μA
Gate - Body Leakage Current	$V_{gs} = -8 V, V_{Ds} = 0 V$			-100	nA
ERISTICS (Note)		1		I	
Gate Threshold Voltage Temp. Coefficient	$I_p = -250 \mu\text{A}$, Referenced to 25 °C		2.1		mV /°C
Gate Threshold Voltage	-	-0.65	-0.86	-1.5	V
				1.5	Ω
					_
On-State Drain Current		-0.5		_	А
Forward Transconductance			0.8		S
ARACTERISTICS					
	$V_{pp} = -10 V, V_{pp} = 0 V,$		63		pF
	f = 1.0 MHz		34		pF
· · ·			10		pF
	L				
	$V_{DD} = -6 V, I_{D} = -0.5 A,$		7	20	ns
Turn - On Rise Time	$V_{GS} = -4.5 \text{ V}, \text{ R}_{GEN} = 50 \Omega$		8	20	ns
Turn - Off Delay Time			55	110	ns
Turn - Off Fall Time			35	70	ns
Total Gate Charge	$V_{pp} = -5 V$, $I_p = -0.25 A$,		1.1	1.5	nC
-	$V_{gs} = -4.5 V$		0.32		nC
-			0.25		nC
•	MUM RATINGS				
				-0.5	А
Drain-Source Diode Forward Voltage	$V_{-1} = 0 V_{-1} = -0.5 A_{-1}$ (Note)		-0.89	-1.2	V
	Gate Threshold Voltage Temp. Coefficient Gate Threshold Voltage Static Drain-Source On-Resistance Dn-State Drain Current Forward Transconductance ARACTERISTICS nput Capacitance Dutput Capacitance Reverse Transfer Capacitance HARACTERISTICS (Note) Turn - On Delay Time Turn - On Rise Time Turn - Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge CE DIODE CHARACTERISTICS AND MAXI	Gate Threshold Voltage Temp. Coefficient $I_{b} = -250 \ \mu$ A, Referenced to 25 °CGate Threshold Voltage $V_{DS} = V_{GS}$, $I_{b} = -250 \ \mu$ AStatic Drain-Source On-Resistance $V_{GS} = -2.7 \ V$, $I_{b} = -0.25 \ A$ $V_{GS} = -4.5 \ V$, $I_{b} = -0.5 \ A$ $V_{GS} = -4.5 \ V$, $I_{b} = -0.5 \ A$ Dn-State Drain Current $V_{GS} = -2.7 \ V$, $V_{DS} = -5 \ V$ $V_{GS} = -4.5 \ V$, $V_{DS} = -5 \ V$ $V_{GS} = -4.5 \ V$, $V_{DS} = -5 \ V$ Dn-State Drain Current $V_{GS} = -2.7 \ V$, $V_{DS} = -5 \ V$ $V_{GS} = -4.5 \ V$, $V_{DS} = -5 \ V$ $V_{GS} = -4.5 \ V$, $V_{DS} = -5 \ V$ Forward Transconductance $V_{DS} = -5 \ V$, $I_{D} = -0.5 \ A$ ARACTERISTICSnput CapacitanceDutput Capacitance $V_{DS} = -10 \ V$, $V_{GS} = 0 \ V$, f = 1.0 MHzHARACTERISTICS (Note) $V_{DD} = -6 \ V$, $I_{D} = -0.5 \ A$, $V_{GS} = -4.5 \ V$, $R_{GEN} = 50 \ \Omega$ furn - On Delay Time $V_{DS} = -5 \ V$, $I_{D} = -0.25 \ A$, $V_{GS} = -4.5 \ V$, $R_{GEN} = 50 \ \Omega$ furn - Off Fall Time $V_{DS} = -5 \ V$, $I_{D} = -0.25 \ A$, $V_{GS} = -4.5 \ V$ foral Gate Charge $V_{DS} = -5 \ V$, $I_{D} = -0.25 \ A$, $V_{GS} = -4.5 \ V$ Gate-Drain Charge $V_{GS} = -4.5 \ V$ CE DIODE CHARACTERISTICS AND MAXIMUM RATINGSMaximum Continuous Drain-Source Diode Forward CurrentDrain-Source Diode Forward Voltage $V_{GS} = 0 \ V$, $I_{S} = -0.5 \ A$ (Note)	Bate Threshold Voltage Temp. CoefficientI_D = -250 μ A, Referenced to 25 °CGate Threshold VoltageV_DS = V_GS, I_D = -250 μ A-0.65Static Drain-Source On-ResistanceV_GS = -2.7 V, I_D = -0.25 A-0.65V_GS = -4.5 V, I_D = -0.5 AT_J = 125°C-0.5On-State Drain CurrentV_GS = -2.7 V, V_DS = -5 V-0.5Torne State Drain CurrentV_GS = -2.7 V, V_DS = -5 V-0.5V_GS = -4.5 V, V_DS = -5 V-0.5-1Forward TransconductanceV_DS = -5 V, I_D = -0.5 A-1ARACTERISTICSNotes = -5 V, I_D = -0.5 A-1Put CapacitanceV_DS = -10 V, V_GS = 0 V, f = 1.0 MHz-1Cutput CapacitanceV_DS = -10 V, V_GS = 0 V, f = 1.0 MHz-1Put CapacitanceV_DS = -4.5 V, I_D = -0.5 A, V_GS = -4.5 V, R_GEN = 50 \Omega-1Turn - On Delay TimeV_DD = -6 V, I_D = -0.5 A, V_GS = -4.5 V, R_GEN = 50 \Omega-1Turn - Off Delay TimeV_DS = -5 V, I_D = -0.25 A, V_GS = -4.5 V-1Total Gate ChargeV_DS = -5 V, I_D = -0.25 A, V_GS = -4.5 V-1Gate-Source ChargeV_DS = -5 V, I_D = -0.25 A, V_GS = -4.5 V-1Gate-Drain ChargeV_DS = -5 V, I_D = -0.25 A, V_GS = -4.5 V-1CE DIODE CHARACTERISTICS AND MAXIMUM RATINGS-1-1Arain-Source Diode Forward VoltageV_GS = 0 V, I_S = -0.5 A (Note)-1	Sate Threshold Voltage Temp. CoefficientI_b = -250 µA, Referenced to 25 °C2.1Sate Threshold Voltage $V_{DS} = V_{GS}$, $I_b = -250 µA$ -0.65-0.86Static Drain-Source On-Resistance $V_{GS} = -2.7$ V, $I_b = -0.25$ A1.22 $V_{GS} = -4.5$ V, $I_b = -0.5$ A0.87T_J = 125°C1.21Dn-State Drain Current $V_{GS} = -2.7$ V, $V_{DS} = -5$ V-0.5 $V_{GS} = -4.5$ V, $V_{DS} = -5$ V-0.5V_{GS} = -4.5 V, $V_{DS} = -5$ V-1Forward Transconductance $V_{DS} = -5$ V, $I_b = -0.5$ A0.8ARACTERISTICSNput Capacitance $V_{DS} = -10$ V, $V_{GS} = 0$ V, $I_b = -0.5$ A0.8Duput Capacitance $V_{DS} = -10$ V, $V_{GS} = 0$ V, $I_b = -0.5$ A,0.8I'um - On Delay Time $V_{DS} = -6$ V, $I_b = -0.5$ A,7Turn - On Rise Time $V_{DS} = -6$ V, $I_b = -0.5$ A,8Turn - Of Delay Time $V_{DS} = -5$ V, $I_b = -0.25$ A,8Turn - Off Fall Time5535Total Gate Charge $V_{DS} = -5$ V, $I_b = -0.25$ A,1.1Sate-Drain Charge $V_{GS} = -4.5$ V0.32Sate-Drain Charge $V_{GS} = -4.5$ V0.32Chorder Charge $V_{GS} = 0$ V, $I_s = -0.5$ A (Note)0.25C DIODE CHARACTERISTICS AND MAXIMUM RATINGS $V_{GS} = 0$ V, $I_s = -0.5$ A (Note)-0.89	Sate Threshold Voltage Temp. Coefficient $I_p = -250 \ \mu$ A, Referenced to 25 °C 2.1 Sate Threshold Voltage $V_{DS} = V_{GS}$, $I_p = -250 \ \mu$ A -0.65 -0.86 -1.5 Static Drain-Source On-Resistance $V_{GS} = -2.7 \ V, I_p = -0.25 \ A$ 1.22 1.5 $V_{GS} = -4.5 \ V, I_p = -0.5 \ A$ 0.87 1.1 $T_{J} = 125^{\circ}$ C 1.21 2 On-State Drain Current $V_{GS} = -2.7 \ V, V_{DS} = -5 \ V$ -0.5 0.87 1.1 Forward Transconductance $V_{DS} = -3.5 \ V, V_{DS} = -5 \ V$ -1 -1 -1 Forward Transconductance $V_{DS} = -10 \ V, V_{DS} = -5 \ V$ -1 -1 -1 Forward Transconductance $V_{DS} = -10 \ V, V_{OS} = 0 \ V, f_{1} = -0.5 \ A$ 0.8 -1 ARACTERISTICS $-10 \ V, V_{OS} = -0.5 \ A, V_{DS} = -0.5 \ A, V_{SS} = -4.5 \ V, R_{GEN} = 50 \ \Omega$ $63 \ 1$ -1 HARACTERISTICS (Note) $-10 \ V_{SS} = -4.5 \ V, R_{GEN} = 50 \ \Omega$ $8 \ 20$ $20 \ V_{OS} = -4.5 \ V, R_{GEN} = 50 \ \Omega$ $8 \ 20$ fun - On Delay Time $V_{SS} = -5. \ V, I_{D} = -0.25 \ A, V_{CS} = -4.5 \ V \ 0.32 \ 2$ $-2.5 \ 0.25 \ 0.25 \ 0.25 \ 0.25 \ $





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